



JAPANESE
INDUSTRIAL
STANDARD

Translated and Published by
Japanese Standards Association

JIS C 5402-11-4 : 2005

(IEC 60512-11-4 : 2002)

(JEITA)

**Connectors for electronic equipment —
Tests and measurements — Part 11-4:
Climatic tests — Test 11d: Rapid
change of temperature**

ICS 31.220.10

Reference number : JIS C 5402-11-4 : 2005 (E)



Documents

Document Sharing Hub

5 S

PROTECTED BY COPYRIGHT

Licensee=Hong Kong Polytechnic University/9976803100
Not for Resale, 07/25/2014 10:05:49 MDT

Foreword

This translation has been made based on the original Japanese Industrial Standard established by the Minister of Economy, Trade and Industry through deliberations at the Japanese Industrial Standards Committee according to the proposal of establishing a Japanese Industrial Standard from Japan Electronics and Information Technology Industries Association (JEITA) with a draft of Industrial Standard based on the provision of Article 12 Clause 1 of the Industrial Standardization Law.

This Standard has been made based on **IEC 60512-11-4:2002 Connectors for electronic equipment — Tests and measurements — Part 11-4: Climatic tests — Test 11d: Rapid change of temperature** for the purposes of making it easier to compare this Standard with International Standard; to prepare Japanese Industrial Standard conforming with International Standard; and to propose a draft of an International Standard which is based on Japanese Industrial Standard.

Attention is drawn to the possibility that some parts of this Standard may conflict with a patent right, application for a patent after opening to the public, utility model right or application for registration of utility model after opening to the public which have technical properties. The relevant Minister and the Japanese Industrial Standards Committee are not responsible for identifying the patent right, application for a patent after opening to the public, utility model right or application for registration of utility model after opening to the public which have the said technical properties.

JIS C 5402 series consists of the standards shown in **JIS C 5402-1-100**.

Date of Establishment: 2005-03-20

Date of Public Notice in Official Gazette: 2005-03-22

Investigated by: Japanese Industrial Standards Committee
Standards Board

Technical Committee on Electronics
Technology

JIS C 5402-11-4 :2005, First English edition published in 2005-06

Translated and published by: Japanese Standards Association
4-1-24, Akasaka, Minato-ku, Tokyo, 107-8440 JAPAN

In the event of any doubts arising as to the contents,
the original JIS is to be the final authority.

© JSA 2005

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from the publisher.

Printed in Japan

Contents

	Page
Introduction	1
1 Scope	1
2 Normative references	1
3 Preparation	2
3.1 Preparation of the specimen	2
3.2 Wiring of specimen	2
3.3 Preconditioning	2
4 Test method	2
4.1 Conditioning	2
5 Measurements	2
5.1 Initial measurements	2
5.2 Final measurements	2
6 Details to be specified	2